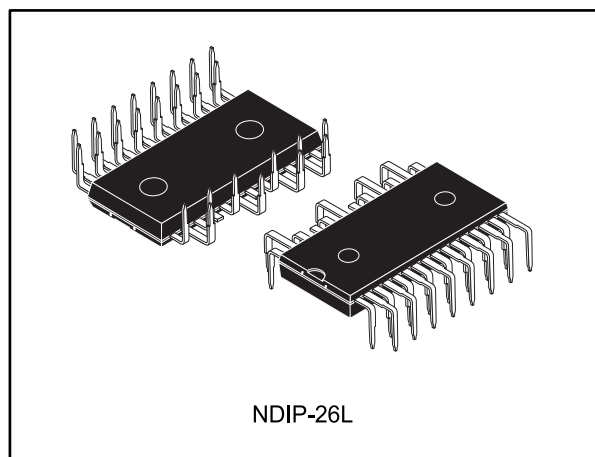


## SLLIMM™-nano small low-loss intelligent molded module IPM, 3 A, 600 V, 3-phase IGBT inverter bridge

Datasheet - production data



### Applications

- 3-phase inverters for motor drives
- Dish washers, refrigerator compressors, heating systems, air-conditioning fans, draining and recirculation pumps

### Description

This SLLIMM (small low-loss intelligent molded module) nano provides a compact, high performance AC motor drive in a simple, rugged design. It is composed of six MOSFETs and three half-bridge HVICs for gate driving, providing low electromagnetic interference (EMI) characteristics with optimized switching speed. The package is optimized for thermal performance and compactness in built-in motor applications, or other low power applications where assembly space is limited. This IPM includes an operational amplifier, completely uncommitted, and a comparator that can be used to design a fast and efficient protection circuit. SLLIMM™ is a trademark of STMicroelectronics.

### Features

- IPM 3 A, 600 V, 3-phase IGBT inverter bridge including control ICs for gate driving and freewheeling diodes
- Optimized for low electromagnetic interference
- $V_{CE(sat)}$  negative temperature coefficient
- 3.3 V, 5 V, 15 V CMOS/TTL input comparators with hysteresis and pull-down/pull-up resistors
- Undervoltage lockout
- Internal bootstrap diode
- Interlocking function
- Smart shutdown function
- Comparator for fault protection against overtemperature and overcurrent
- Op-amp for advanced current sensing
- Optimized pinout for board layout
- NTC for temperature control (UL 1434 CA 2 and 4)

Table 1: Device summary

Order code	Marking	Package	Packing
STGIPN3H60T-H	GIPN3H60T-H	NDIP-26L	Tube

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# 1 Internal schematic diagram and pin configuration

Figure 1: Internal schematic diagram

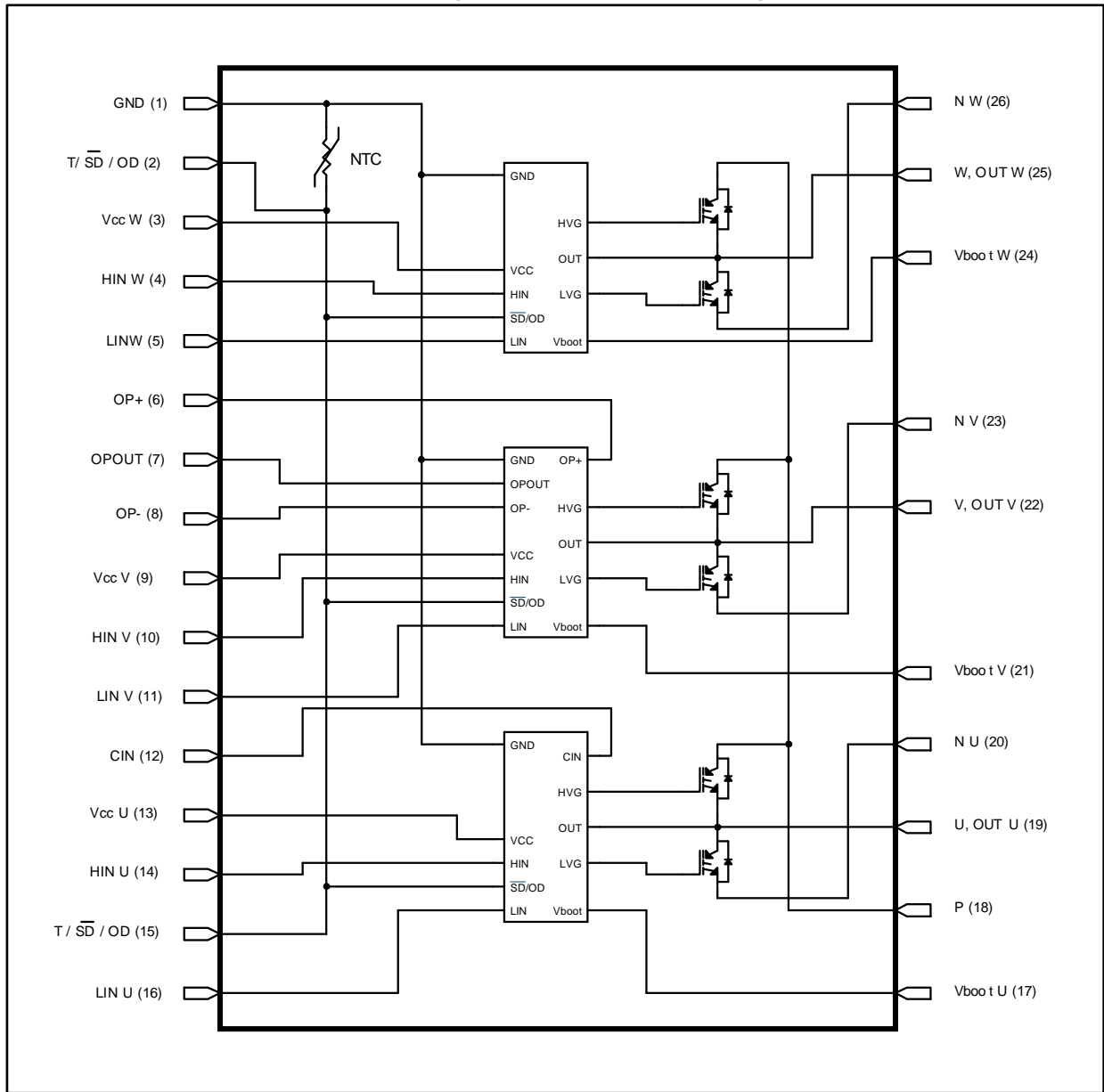


Table 2: Pin description

Pin	Symbol	Description
1	GND	Ground
2	T/ $\overline{\text{SD}}$ / OD	NTC thermistor terminal / shutdown logic input (active low) / open-drain (comparator output)
3	V <sub>CC</sub> W	Low voltage power supply W phase
4	HIN W	High-side logic input for W phase
5	LIN W	Low-side logic input for W phase
6	OP+	Op-amp non-inverting input
7	OP <sub>OUT</sub>	Op-amp output
8	OP-	Op-amp inverting input
9	V <sub>CC</sub> V	Low voltage power supply V phase
10	HIN V	High-side logic input for V phase
11	LIN V	Low-side logic input for V phase
12	CIN	Comparator input
13	V <sub>CC</sub> U	Low voltage power supply for U phase
14	HIN U	High-side logic input for U phase
15	T/ $\overline{\text{SD}}$ / OD	NTC thermistor terminal / shutdown logic input (active low) / open-drain (comparator output)
16	LIN U	Low-side logic input for U phase
17	V <sub>BOOT</sub> U	Bootstrap voltage for U phase
18	P	Positive DC input
19	U, OUT <sub>U</sub>	U phase output
20	N <sub>U</sub>	Negative DC input for U phase
21	V <sub>BOOT</sub> V	Bootstrap voltage for V phase
22	V, OUT <sub>V</sub>	V phase output
23	N <sub>V</sub>	Negative DC input for V phase
24	V <sub>BOOT</sub> W	Bootstrap voltage for W phase
25	W, OUT <sub>W</sub>	W phase output
26	N <sub>W</sub>	Negative DC input for W phase

Figure 2: Pin layout (top view)



## 2 Electrical ratings

### 2.1 Absolute maximum ratings

Table 3: Inverter part

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Each IGBT collector emitter voltage (V <sub>IN</sub> <sup>(1)</sup> = 0)	600	V
± I <sub>C</sub> <sup>(2)</sup>	Each IGBT continuous collector current at T <sub>C</sub> = 25 °C	3	A
± I <sub>CP</sub> <sup>(3)</sup>	Each IGBT pulsed collector current	18	A
P <sub>TOT</sub>	Each IGBT total dissipation at T <sub>C</sub> = 25 °C	8	W

**Notes:**

<sup>(1)</sup>Applied among HIN<sub>i</sub>, LIN<sub>i</sub> and GND for i = U, V, W.

<sup>(2)</sup>Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{j(max)} - T_C}{R_{thj-c} \times V_{CE(sat)(max)}(T_{j(max)}, I_C(T_C))}$$

<sup>(3)</sup>Pulse width limited by max. junction temperature.

Table 4: Control part

Symbol	Parameter	Min.	Max.	Unit
V <sub>OUT</sub>	Output voltage applied among OUT <sub>U</sub> , OUT <sub>V</sub> , OUT <sub>W</sub> - GND	V <sub>boot</sub> - 21	V <sub>boot</sub> + 0.3	V
V <sub>CC</sub>	Low voltage power supply	- 0.3	21	V
V <sub>CIN</sub>	Comparator input voltage	- 0.3	V <sub>CC</sub> + 0.3	V
V <sub>op+</sub>	Op-amp non-inverting input	- 0.3	V <sub>CC</sub> + 0.3	V
V <sub>op-</sub>	Op-amp inverting input	- 0.3	V <sub>CC</sub> + 0.3	V
V <sub>boot</sub>	Bootstrap voltage	- 0.3	620	V
V <sub>IN</sub>	Logic input voltage applied among HIN, LIN and GND	- 0.3	15	V
V <sub>T/SD/OD</sub>	Open-drain voltage	- 0.3	15	V
ΔV <sub>OUT/dT</sub>	Allowed output slew rate		50	V/ns

Table 5: Total system

Symbol	Parameter	Value	Unit
V <sub>ISO</sub>	Isolation withstand voltage applied among each pin and heatsink plate (AC voltage, t = 60 s)	1000	V
T <sub>j</sub>	Power chip operating junction temperature range	-40 to 150	°C
T <sub>C</sub>	Module operation case temperature range	-40 to 125	°C

## 2.2 Thermal data

Table 6: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thJA</sub>	Thermal resistance junction-ambient	50	°C/W

### 3 Electrical characteristics

#### 3.1 Inverter part

$T_J = 25\text{ °C}$  unless otherwise specified.

**Table 7: Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 0\text{ to }5\text{ V}$ , $I_C = 1\text{ A}$	-	2.15	2.6	V
		$V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 0\text{ to }5\text{ V}$ , $I_C = 1\text{ A}$ , $T_J = 125\text{ °C}$	-	1.65		
$I_{CES}$	Collector cut-off current ( $V_{IN}^{(1)} = 0$ "logic state")	$V_{CE} = 550\text{ V}$ , $V_{CC} = V_{boot} = 15\text{ V}$	-		250	$\mu\text{A}$
$V_F$	Diode forward voltage	$V_{IN}^{(1)} = 0$ "logic state", $I_C = 1\text{ A}$	-		1.7	V

**Notes:**

<sup>(1)</sup>Applied among  $HIN_i$ ,  $LIN_i$  and  $GND$  for  $i = U, V, W$ .

**Table 8: Inductive load switching time and energy**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{on}^{(1)}$	Turn-on time	$V_{DD} = 300\text{ V}$ , $V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(2)} = 0\text{ to }5\text{ V}$ , $I_C = 1\text{ A}$ (see <a href="#">Figure 4: "Switching time definition"</a> )	-	275	-	ns
$t_{c(on)}^{(1)}$	Crossover time (on)		-	90	-	
$t_{off}^{(1)}$	Turn-off time		-	890	-	
$t_{c(off)}^{(1)}$	Crossover time (off)		-	125	-	
$t_{rr}$	Reverse recovery time		-	50	-	
$E_{on}$	Turn-on switching energy		-	18	-	$\mu\text{J}$
$E_{off}$	Turn-off switching energy		-	13	-	

**Notes:**

<sup>(1)</sup> $t_{ON}$  and  $t_{OFF}$  include the propagation delay time of the internal drive.  $t_{c(ON)}$  and  $t_{c(OFF)}$  are the switching time of MOSFET itself under the internally given gate driving conditions.

<sup>(2)</sup>Applied among  $HIN_i$ ,  $LIN_i$  and  $GND$  for  $i = U, V, W$ .



Figure 3: Switching time test circuit

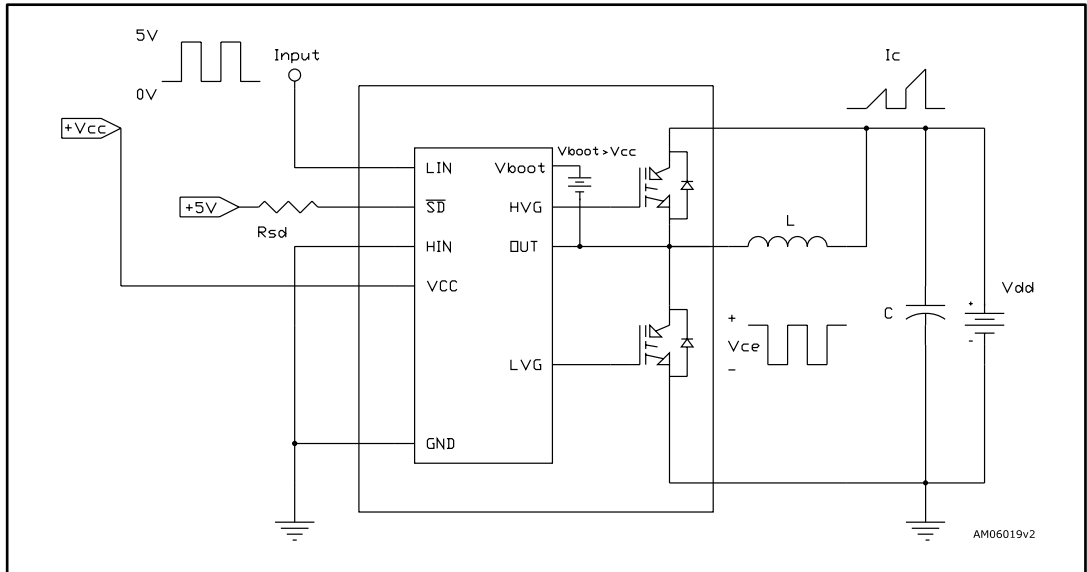


Figure 4: Switching time definition

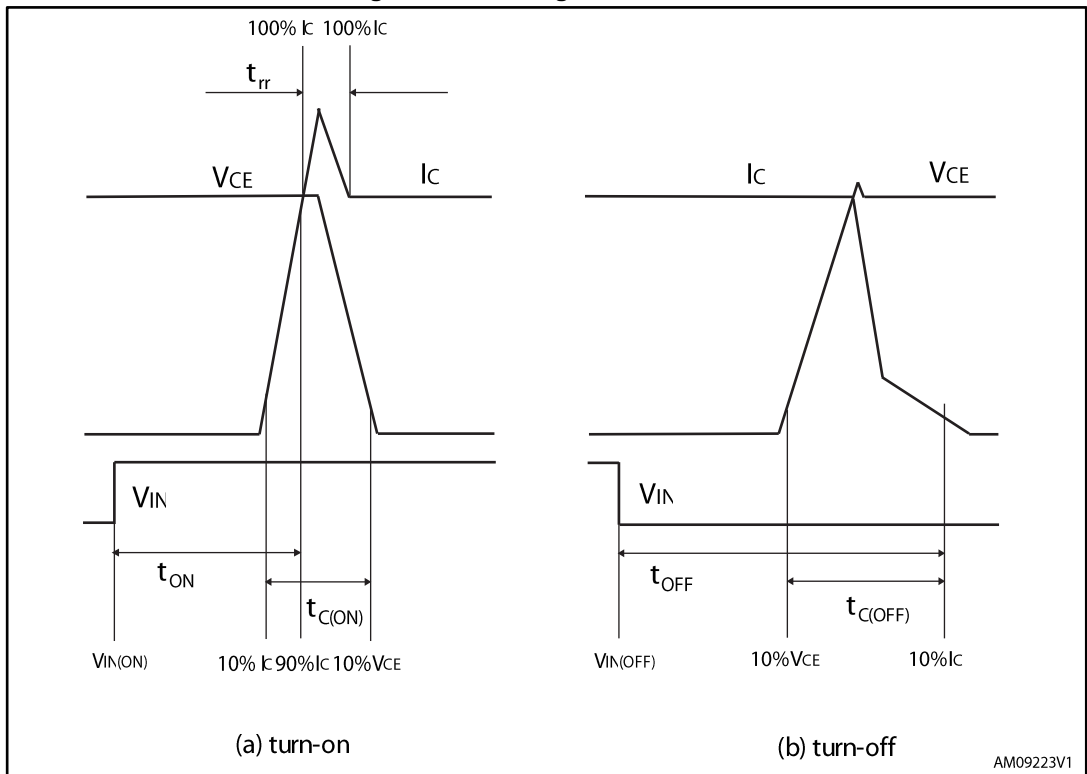


Figure 4: "Switching time definition" refers to HIN, LIN inputs (active high).

### 3.2 Control part

Table 9: Low voltage power supply ( $V_{CC} = 15\text{ V}$  unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{CC\_hys}$	$V_{CC}$ UV hysteresis		1.2	1.5	1.8	V
$V_{CC\_thON}$	$V_{CC}$ UV turn-ON threshold		11.5	12	12.5	V
$V_{CC\_thOFF}$	$V_{CC}$ UV turn-OFF threshold		10	10.5	11	V
$I_{qccu}$	Undervoltage quiescent supply current	$V_{CC} = 10\text{ V}$ , $T/\overline{SD}$ /OD = 5 V; LIN = 0, HIN = 0, CIN = 0 V			150	$\mu\text{A}$
$I_{qcc}$	Quiescent current	$V_{CC} = 15\text{ V}$ , $T/\overline{SD}$ /OD = 5 V; LIN = 0; HIN = 0, CIN = 0 V			1	mA
$V_{ref}$	Internal comparator (CIN) reference voltage		0.5	0.54	0.58	V

Table 10: Bootstrapped voltage ( $V_{CC} = 15\text{ V}$  unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{BS\_hys}$	$V_{BS}$ UV hysteresis		1.2	1.5	1.8	V
$V_{BS\_thON}$	$V_{BS}$ UV turn-ON threshold		11.1	11.5	12.1	V
$V_{BS\_thOFF}$	$V_{BS}$ UV turn-OFF threshold		9.8	10	10.6	V
$I_{QBSU}$	Undervoltage $V_{BS}$ quiescent current	$V_{BS} < 9\text{ V}$ , $T/\overline{SD}$ /OD = 5 V, LIN = 0 HIN=5 V, CIN = 0 V		70	110	$\mu\text{A}$
$I_{QBS}$	$V_{BS}$ quiescent current	$V_{BS} = 15\text{ V}$ , $T/\overline{SD}$ /OD = 5 V, LIN = 0 HIN=5 V, CIN = 0 V		150	210	$\mu\text{A}$
$R_{DS(on)}$	Bootstrap driver on-resistance	LVG ON		120		$\Omega$

Table 11: Logic inputs ( $V_{CC} = 15\text{ V}$  unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{il}$	Low logic level voltage				0.8	V
$V_{ih}$	High logic level voltage		2.25			V
$I_{HINh}$	HIN logic "1" input bias current	HIN = 15 V	20	40	100	$\mu\text{A}$
$I_{HINl}$	HIN logic "0" input bias current	HIN = 0 V			1	$\mu\text{A}$
$I_{LINh}$	LIN logic "1" input bias current	LIN = 15 V	20	40	100	$\mu\text{A}$
$I_{LINl}$	LIN logic "0" input bias current	LIN = 0 V			1	$\mu\text{A}$
$I_{SDh}$	$\overline{SD}$ logic "0" input bias current	$\overline{SD} = 15\text{ V}$	220	295	370	$\mu\text{A}$
$I_{SDl}$	$\overline{SD}$ logic "1" input bias current	$\overline{SD} = 0\text{ V}$			3	$\mu\text{A}$
Dt	Dead time	see <a href="#">Figure 9: "Dead time and interlocking waveform definitions"</a>		180		ns

Table 12: Op-amp characteristics ( $V_{CC} = 15\text{ V}$  unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{io}$	Input offset voltage	$V_{ic} = 0\text{ V}$ , $V_o = 7.5\text{ V}$			6	mV
$I_{io}$	Input offset current	$V_{ic} = 0\text{ V}$ , $V_o = 7.5\text{ V}$		4	40	nA
$I_{ib}$	Input bias current <sup>(1)</sup>			100	200	nA
$V_{icm}$	Input common mode voltage range		0			V
$V_{OL}$	Low level output voltage	$R_L = 10\text{ k}\Omega$ to $V_{CC}$		75	150	mV
$V_{OH}$	High level output voltage	$R_L = 10\text{ k}\Omega$ to GND	14	14.7		V
$I_o$	Output short-circuit current	Source, $V_{id} = +1\text{ V}$ ; $V_o = 0\text{ V}$	16	30		mA
		Sink, $V_{id} = -1\text{ V}$ ; $V_o = V_{CC}$	50	80		mA
SR	Slew rate	$V_i = 1 - 4\text{ V}$ ; $C_L = 100\text{ pF}$ ; unity gain	2.5	3.8		V/ $\mu$ s
GBWP	Gain bandwidth product	$V_o = 7.5\text{ V}$	8	12		MHz
$A_{vd}$	Large signal voltage gain	$R_L = 2\text{ k}\Omega$	70	85		dB
SVR	Supply voltage rejection ratio	vs. $V_{CC}$	60	75		dB
CMRR	Common mode rejection ratio		55	70		dB

**Notes:**

<sup>(1)</sup>The direction of input current is out of the IC.

Table 13: Sense comparator characteristics ( $V_{CC} = 15\text{ V}$  unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{ib}$	Input bias current	$V_{CIN} = 1\text{ V}$			3	$\mu$ A
$V_{od}$	Open-drain low level output voltage	$I_{od} = 3\text{ mA}$			0.5	V
$R_{ON\_OD}$	Open-drain low level output resistance	$I_{od} = 3\text{ mA}$		166		$\Omega$
$R_{PD\_SD}$	$\overline{SD}$ pull-down resistor <sup>(1)</sup>			125		k $\Omega$
$t_{d\_comp}$	Comparator delay	T/ $\overline{SD}$ /OD pulled to 5 V through 100 k $\Omega$ resistor		90	130	ns
SR	Slew rate	$C_L = 180\text{ pF}$ ; $R_{pu} = 5\text{ k}\Omega$		60		V/ $\mu$ s
$t_{sd}$	Shutdown to high / low-side driver propagation delay	$V_{OUT} = 0$ , $V_{boot} = V_{CC}$ , $V_{IN} = 0$ to 3.3 V	50	125	200	ns
$t_{isd}$	Comparator triggering to high / low-side driver turn-off propagation delay	Measured applying a voltage step from 0 V to 3.3 V to pin CIN	50	200	250	

**Notes:**

<sup>(1)</sup>Equivalent value derived from the resistances of three drivers in parallel

Table 14: Truth table

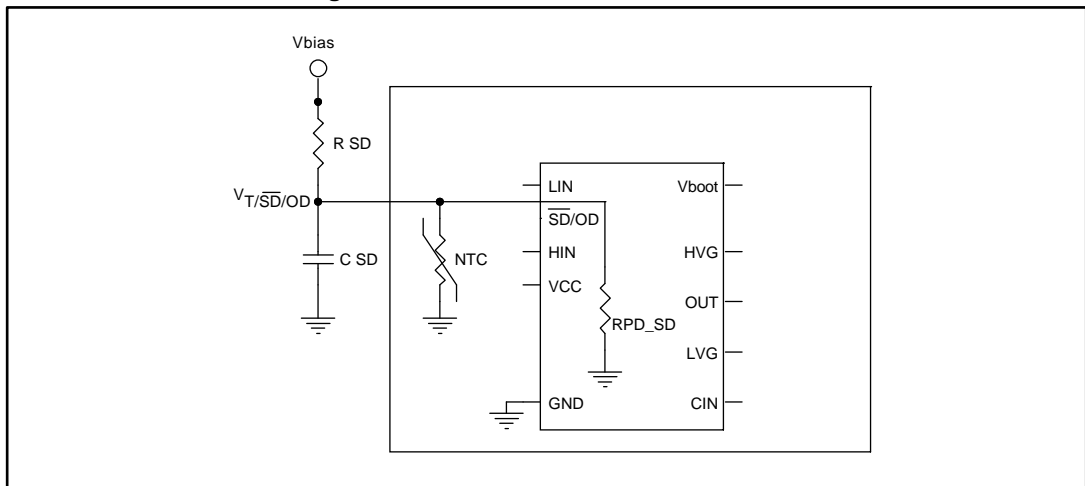
Condition	Logic input (Vi)			Output	
	T/ $\overline{SD}$ /OD	LIN	HIN	LVG	HVG
Shutdown enable half-bridge tri-state	L	X <sup>(1)</sup>	X <sup>(1)</sup>	L	L
Interlocking half-bridge tri-state	H	H	H	L	L
0 “logic state” half-bridge tri-state	H	L	L	L	L
1 “logic state” low-side direct driving	H	H	L	H	L
1 “logic state” high-side direct driving	H	L <td>H</td> <td>L</td> <td>H</td>	H	L	H

**Notes:**

<sup>(1)</sup>X: don't care.

**3.2.1 NTC thermistor**

Figure 5: Internal structure of  $\overline{SD}$  and NTC



RPD\_SD: equivalent value as result of resistances of three drivers in parallel.

Figure 6: Equivalent resistance (NTC//RPD\_SD)

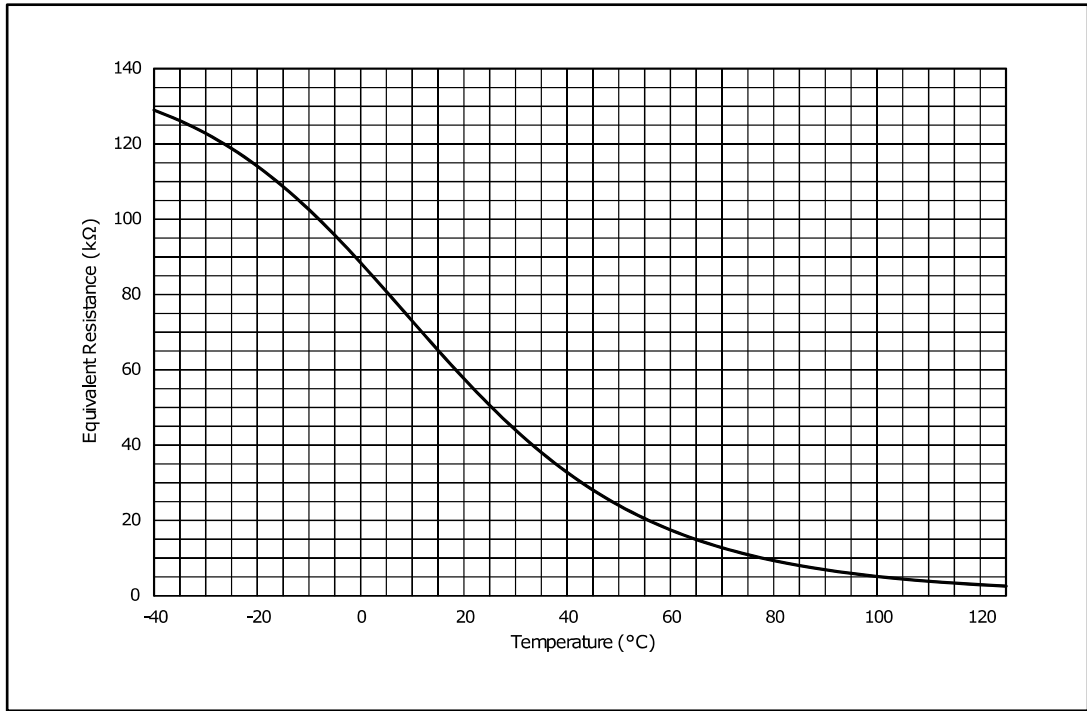


Figure 7: Equivalent resistance (NTC//RPD\_SD zoom)

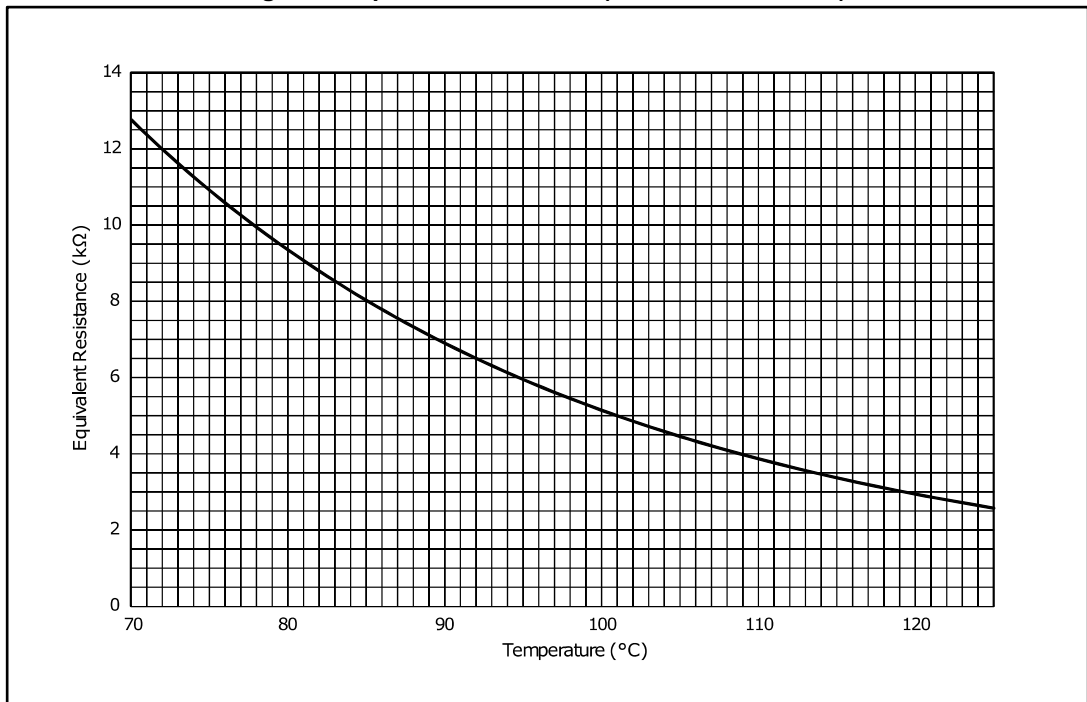
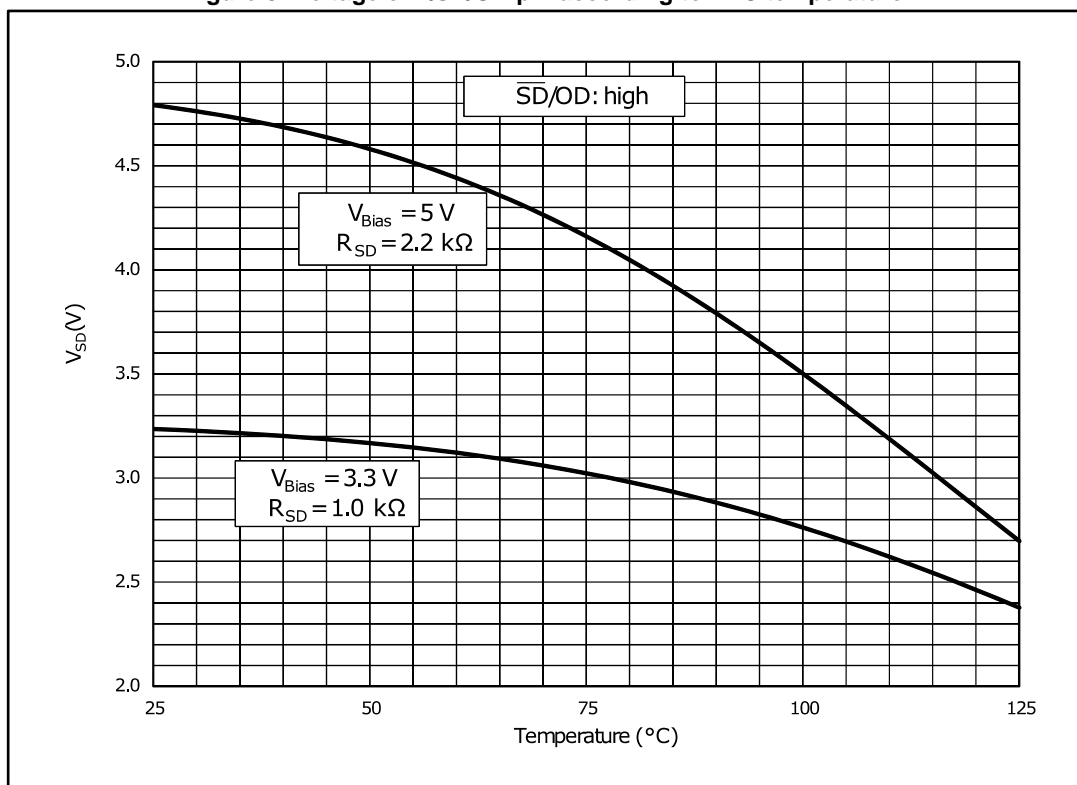
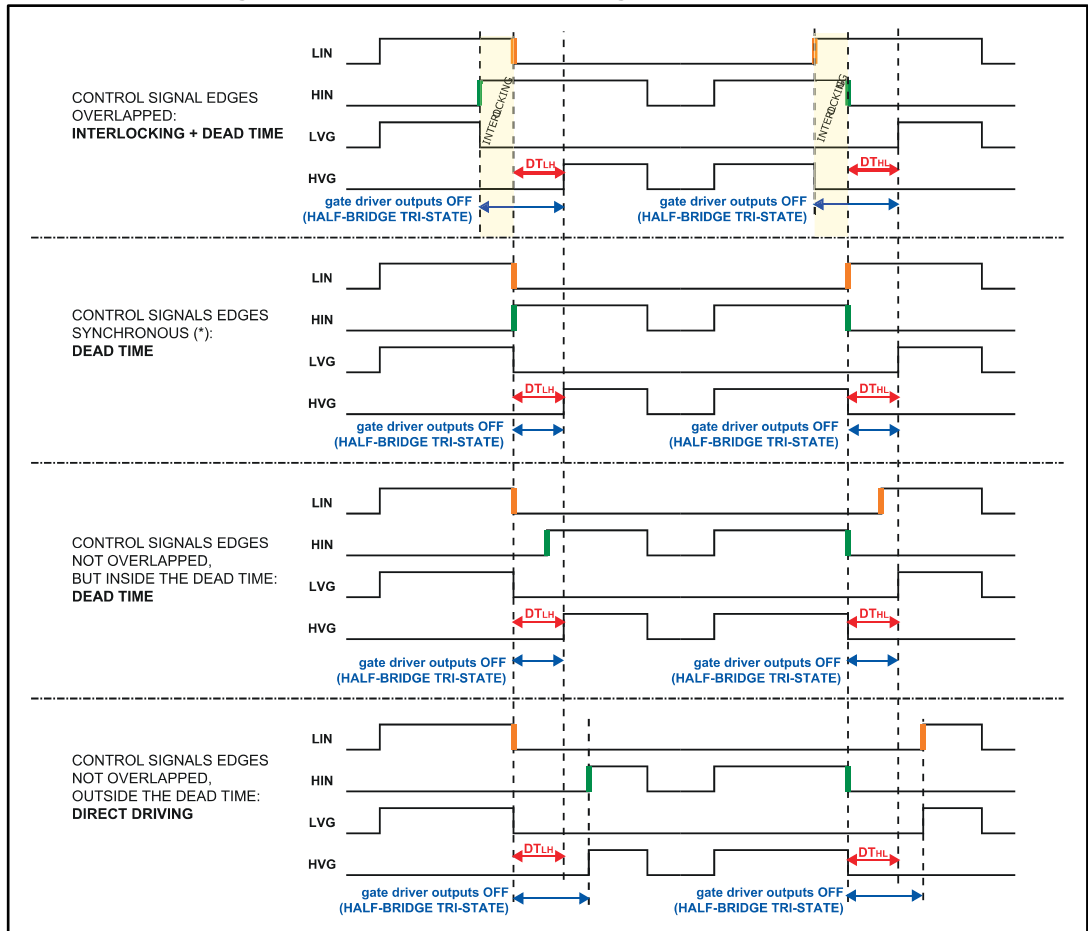


Figure 8: Voltage of T/SD/OD pin according to NTC temperature



### 3.3 Waveform definitions

Figure 9: Dead time and interlocking waveform definitions



## 4 Smart shutdown function

The device integrates a comparator for fault sensing purposes. The comparator has an internal voltage reference  $V_{REF}$  connected to the inverting input, while the non-inverting input on pin (C<sub>IN</sub>) can be connected to an external shunt resistor for simple overcurrent protection.

When the comparator triggers, the device goes to the shutdown state and both of its outputs are set to low level, causing the half-bridge to enter tri-state.

In common overcurrent protection architectures, the comparator output is usually connected to the shutdown input through an RC network so to provide a monostable circuit which implements a protection time following to a fault condition.

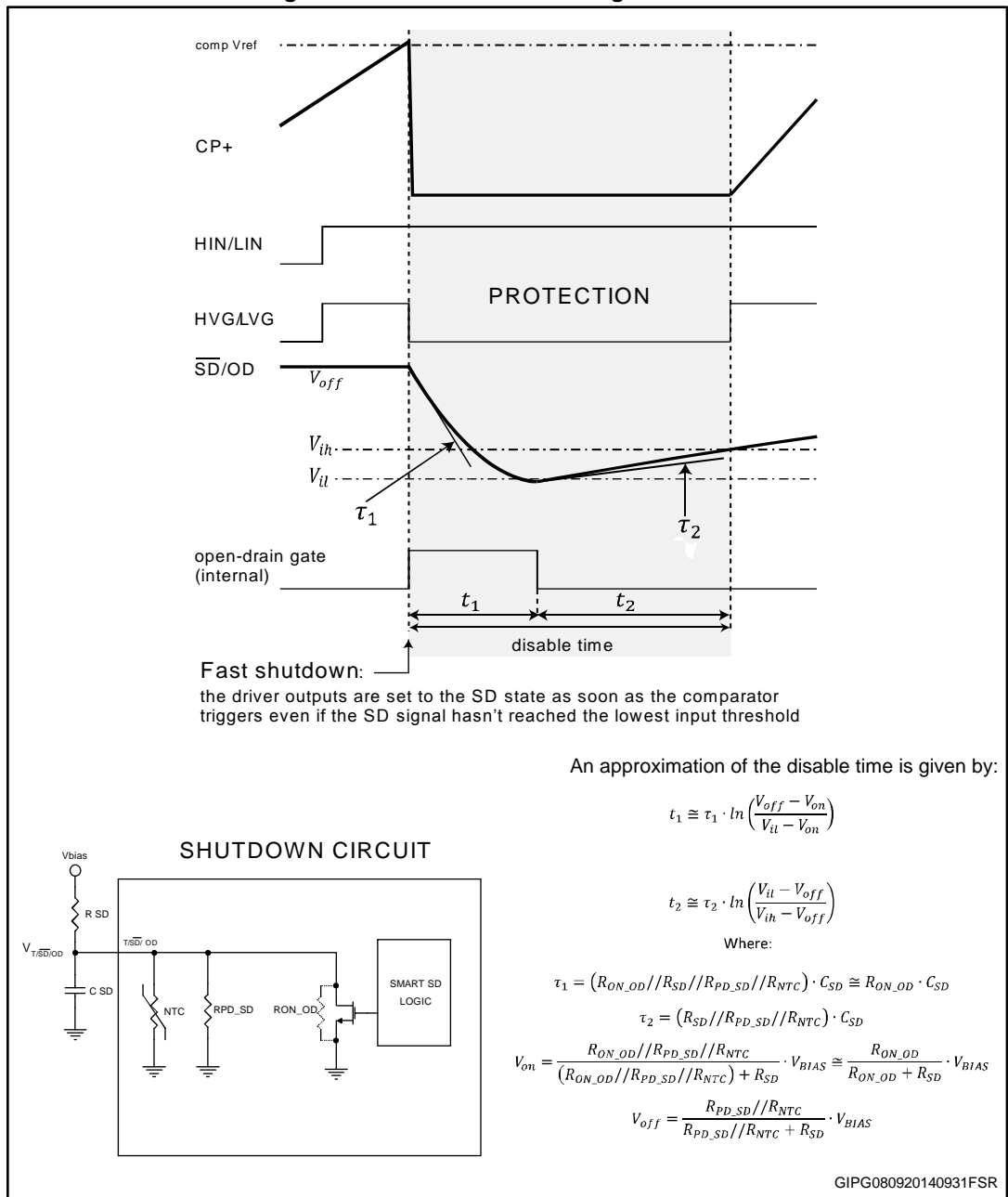
Our smart shutdown architecture immediately turns off the output gate driver in case of overcurrent through a preferential path for the fault signal, which directly switches off the outputs. The time delay between the fault and output shutdown no longer depends on the RC values of the external network connected to the shutdown pin. At the same time, the DMOS connected to the open-drain output (pin T/  $\overline{SD}$  /OD) is turned on by the internal logic, which holds it on until the shutdown voltage is lower than the minimum value of logic input threshold ( $V_{il}$ ).

Besides, the smart shutdown function allows the real disable time to be increased while the constant time of the external RC network remains as it is.

An NTC thermistor for temperature monitoring is internally connected in parallel to the  $\overline{SD}$  pin. To avoid undesired shutdown, keep the voltage  $V_{T/\overline{SD}/OD}$  higher than the high level logic threshold by setting the pull-up resistor  $R_{\overline{SD}}$  to 1 k $\Omega$  or 2.2 k $\Omega$  for the 3.3 V or 5 V MCU power supplies, respectively.



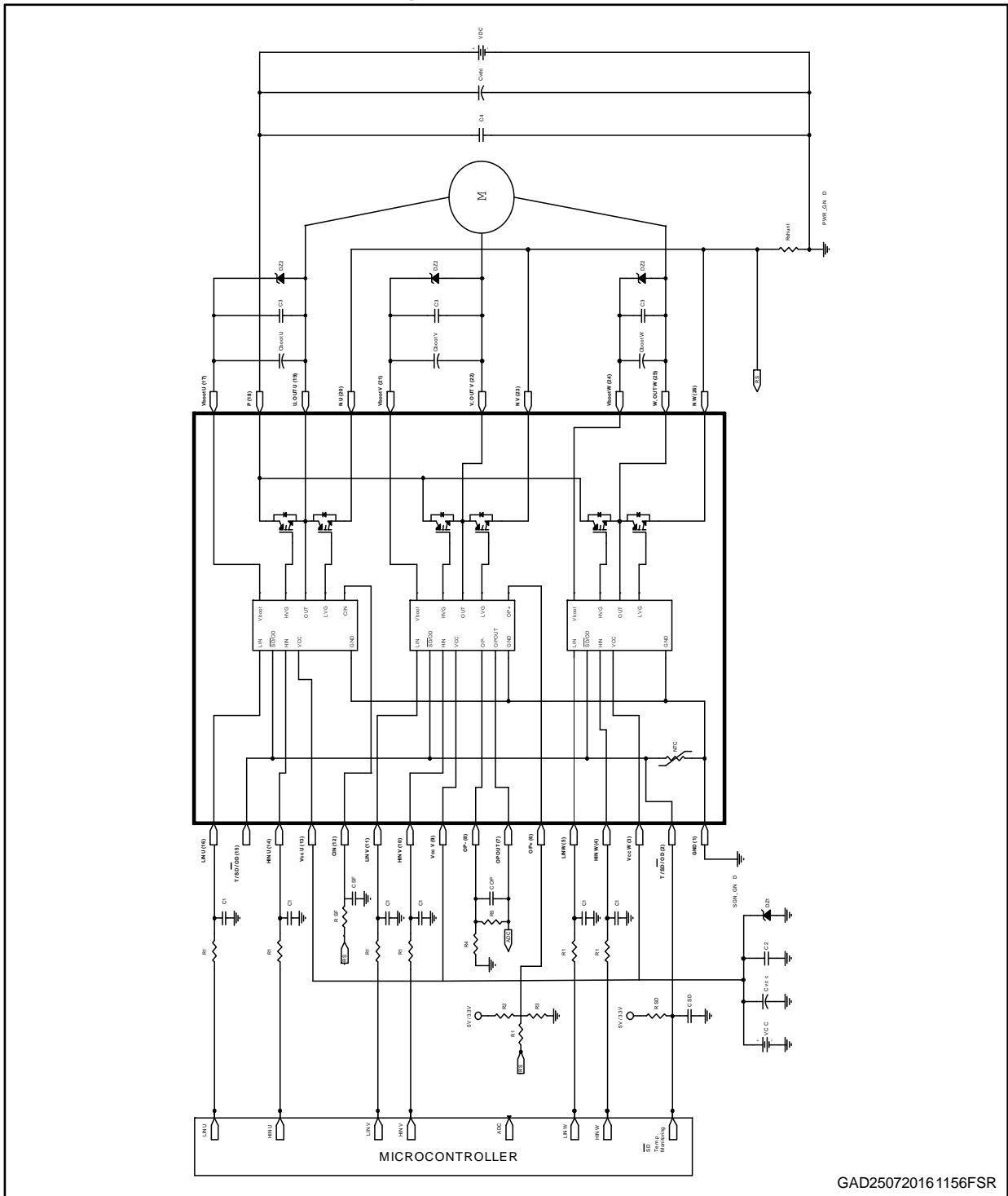
Figure 10: Smart shutdown timing waveforms



Please refer to [Table 13: "Sense comparator characteristics \(VCC = 15 V unless otherwise specified\)"](#) for internal propagation delay time details.

# 5 Application circuit example

Figure 11: Application circuit example



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Application designers are free to use a different scheme according to the specifications of the device.

## 5.1 Guidelines

- Input signals HIN, LIN are active high logic. A 375 k $\Omega$  (typ.) pull-down resistor is built-in for each input. To avoid the input signal oscillation, the wiring of each input should be as short as possible and the use of RC filters ( $R_1$ ,  $C_1$ ) on each input signal is suggested. The filters should be with a time constant of about 100 ns and placed as close as possible to the IPM input pins.
  - The use of a bypass capacitor  $C_{VCC}$  (aluminum or tantalum) can help to reduce the transient circuit demand on the power supply. Besides, to reduce high frequency switching noise distributed on the power lines, a decoupling capacitor  $C_2$  (100 to 220 nF, with low ESR and low ESL) should be placed as close as possible to  $V_{CC}$  pin and in parallel with the bypass capacitor.
  - The use of an RC filter ( $R_{SF}$ ,  $C_{SF}$ ) is recommended to avoid protection circuit malfunction. The time constant ( $R_{SF} \times C_{SF}$ ) should be set to 1  $\mu$ s and the filter must be placed as close as possible to the  $C_{IN}$  pin.
  - The  $\overline{SD}$  is an input/output pin (open-drain type if it is used as output). A built-in thermistor NTC is internally connected between the  $\overline{SD}$  pin and GND. The voltage  $V_{SD-GND}$  decreases as the temperature increases, due to the pull-up resistor  $R_{SD}$ . In order to keep the voltage always higher than the high level logic threshold, the pull-up resistor is suggested to be set to 1 k $\Omega$  or 2.2 k $\Omega$  for 3.3 V or 5 V MCU power supply, respectively. The  $C_{SD}$  capacitor of the filter on  $\overline{SD}$  should be fixed no higher than 3.3 nF to ensure the  $\overline{SD}$  activation time  $\tau_1 \leq 500$  ns; the filter should be placed as close as possible to the  $\overline{SD}$  pin.
  - The decoupling capacitor  $C_3$  (from 100 to 220 nF, ceramic with low ESR and low ESL), in parallel with each  $C_{boot}$ , filters the high frequency disturbance. Both  $C_{boot}$  and  $C_3$  (if present) should be placed as close as possible to the U, V, W and  $V_{boot}$  pins. Bootstrap negative electrodes should be connected to U, V, W terminals directly and separated from the main output wires.
  - To prevent the overvoltage on  $V_{CC}$  pin, a Zener diode (Dz1) can be used. Similarly on the  $V_{boot}$  pin, a Zener diode (Dz2) can be placed in parallel with each  $C_{boot}$ .
  - The use of the decoupling capacitor  $C_4$  (100 to 220 nF, with low ESR and low ESL) in parallel with the electrolytic capacitor  $C_{vdc}$  avoids surge destruction. Both capacitors  $C_4$  and  $C_{vdc}$  should be placed as close as possible to the IPM ( $C_4$  has priority over  $C_{vdc}$ ).
  - By integrating an application specific type HVIC inside the module, direct coupling to the MCU terminals without an optocoupler is possible.
  - Low inductance shunt resistors should be used for phase leg current sensing.
  - In order to avoid malfunctions, the wiring among N pins, the shunt resistor and PWR\_GND should be as short as possible.
- These guidelines ensure the specifications of the device for the application design. For further details, please refer to the relevant application note AN4043.

Table 15: Recommended operating conditions

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{PN}$	Supply voltage	Applied among P-Nu, Nv, Nw		300	500	V
$V_{CC}$	Control supply voltage	Applied to $V_{CC-GND}$	13.5	15	18	V
$V_{BS}$	High-side bias voltage	Applied to $V_{BOOTi-OUTi}$ for $i = U, V, W$	13		18	V
$t_{dead}$	Blanking time to prevent arm-short	For each input signal	1.5			$\mu s$
$f_{PWM}$	PWM input signal	$-40\text{ }^{\circ}\text{C} < T_c < 100\text{ }^{\circ}\text{C}$ $-40\text{ }^{\circ}\text{C} < T_j < 125\text{ }^{\circ}\text{C}$			25	kHz
$T_c$	Case operation temperature				100	$^{\circ}\text{C}$

## 6 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 6.1 NDIP-26L type C package information

Figure 12: NDIP-26L type C package outline

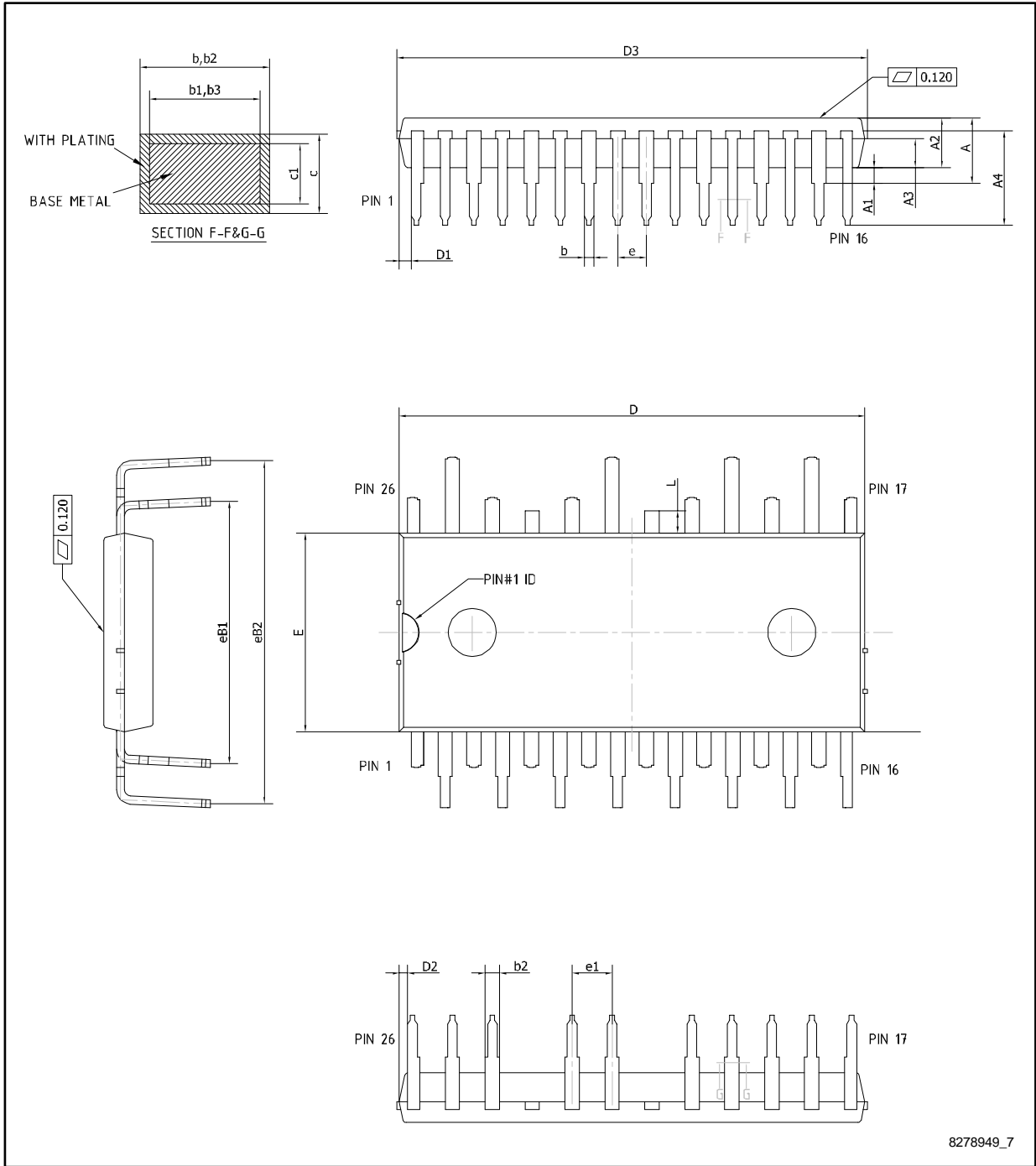


Table 16: NDIP-26L type C mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A			4.40
A1	0.80	1.00	1.20
A2	3.00	3.10	3.20
A3	1.70	1.80	1.90
A4	5.70	5.90	6.10
b	0.53		0.72
b1	0.52	0.60	0.68
b2	0.83		1.02
b3	0.82	0.90	0.98
c	0.46		0.59
c1	0.45	0.50	0.55
D	29.05	29.15	29.25
D1	0.50	0.77	1.00
D2	0.35	0.53	0.70
D3			29.55
E	12.35	12.45	12.55
e	1.70	1.80	1.90
e1	2.40	2.50	2.60
eB1	16.10	16.40	16.70
eB2	21.18	21.48	21.78
L	1.24	1.39	1.54

## 6.2 NDIP-26L packing information

Figure 13: NDIP-26L tube (dimensions are in mm)

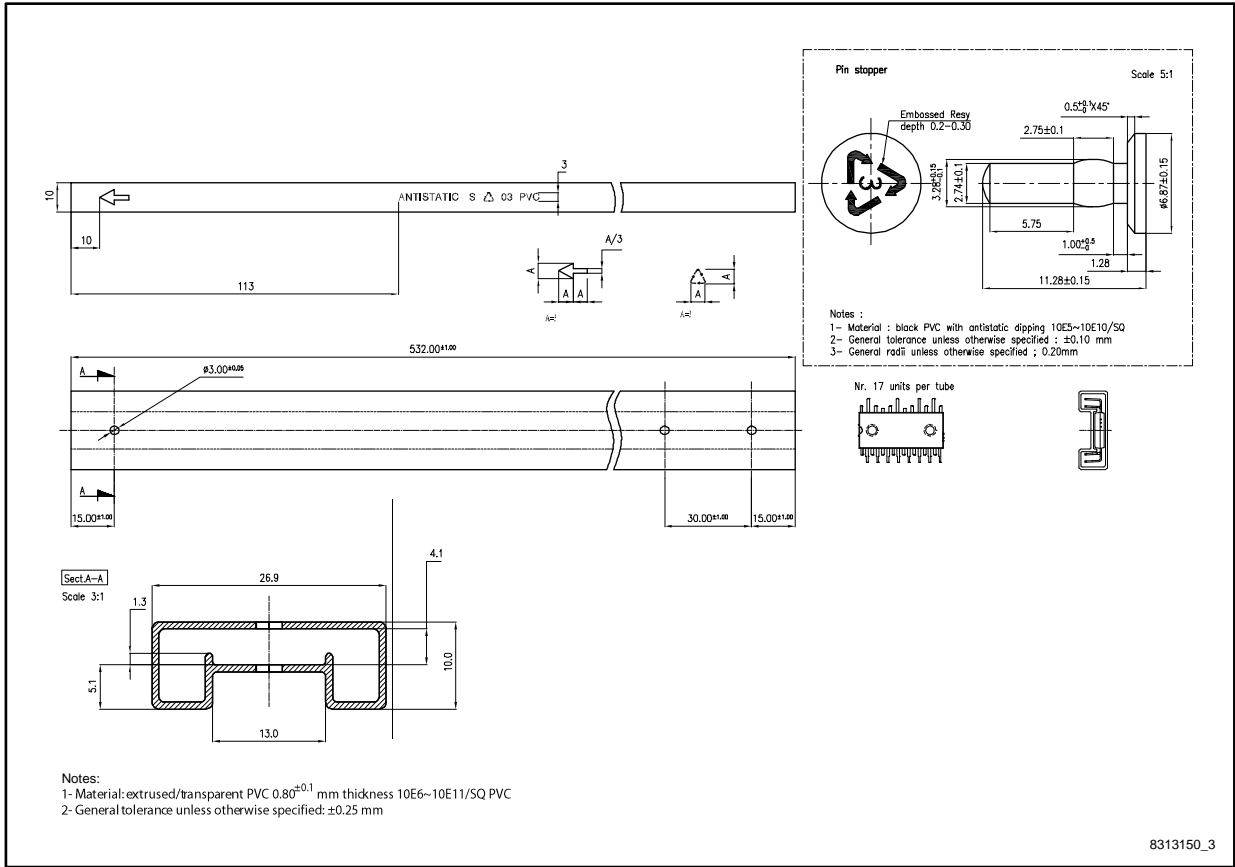


Table 17: Shipping details

Parameter	Value
Base quantity	17 pieces
Bulk quantity	476 pieces



## 7 Revision history

**Table 18: Document revision history**

Date	Revision	Changes
19-Dec-2013	1	Initial release.
23-Apr-2014	2	Updated <i>Figure 1: Internal schematic diagram</i> and <i>Section 3: Electrical characteristics</i> . Minor text changes.
05-May-2014	3	Updated features in cover page.
04-Nov-2014	4	Updated: <ul style="list-style-type: none"> <li>– <i>Figure 1: Internal schematic diagram</i></li> <li>– <i>Table 10: Logic inputs (VCC = 15 V unless otherwise specified)</i></li> <li>– <i>Table 12: Sense comparator characteristics (VCC = 15 V unless otherwise specified)</i></li> <li>– <i>Section 3.1.1: NTC thermistor</i></li> <li>– <i>Section 4: Smart shutdown function description</i></li> <li>– <i>Figure 10: Smart shutdown timing waveforms</i></li> <li>– <i>Figure 11: Typical application circuit</i></li> <li>– <i>Section 5.1: Recommendations</i></li> <li>– minor text changes</li> </ul>
07-Nov-2014	5	Minor text and formatting edits throughout document.
08-Jun-2015	6	Updated <i>Section 6: Package information</i> . Minor text changes.
16-Mar-2017	7	Updated <i>Section 6.1: "NDIP-26L type C package information"</i> and <i>Section 6.2: "NDIP-26L packing information"</i> . Minor text changes

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